<u>MOSFET</u> – Power, Single N-Channel 40 V, 17.3 mΩ, 27 A

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFWS015N04C Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

Parar	Symbol	Value	Unit		
Drain-to-Source Voltag	V _{DSS}	40	V		
Gate-to-Source Voltage	Э		V _{GS}	±20	V
Continuous Drain		$T_{C} = 25^{\circ}C$	۱ _D	27	А
Current R _{θJC} (Notes 1, 2, 3, 4)	Steady	T _C = 100°C		15	
Power Dissipation	State	$T_C = 25^{\circ}C$	PD	23	W
$R_{\theta JC}$ (Notes 1, 2, 3)		$T_C = 100^{\circ}C$		7.4	
Continuous Drain		$T_A = 25^{\circ}C$	۱ _D	9.4	А
Current R _{θJA} (Notes 1, 3, 4)	Steady State	T _A = 100°C		6.7	
Power Dissipation		T _A = 25°C	PD	2.9	W
R _{θJA} (Notes 1, 3)		$T_A = 100^{\circ}C$		1.5	
Pulsed Drain Current	T _A = 25	°C, t _p = 10 μs	I _{DM}	93	А
Operating Junction and Range	T _J , T _{stg}	–55 to +175	°C		
Source Current (Body D	۱ _S	19	А		
Single Pulse Drain-to-S Energy (I _{L(pk)} = 1.4 A)	E _{AS}	43	mJ		
Lead Temperature for S (1/8" from case for 10 s)	ΤL	260	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 3)	$R_{\theta JC}$	6.4	°C/W
Junction-to-Ambient - Steady State (Note 3)	R _{0.IA}	51.5	

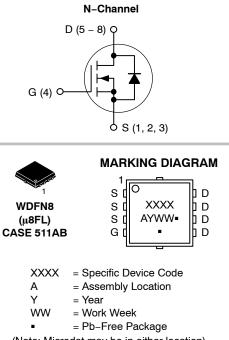
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi (Ψ) is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 4. Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
40 V	17.3 mΩ @ 10 V	27 A



(Note: Microdot may be in either location)

ORDERING INFORMATION

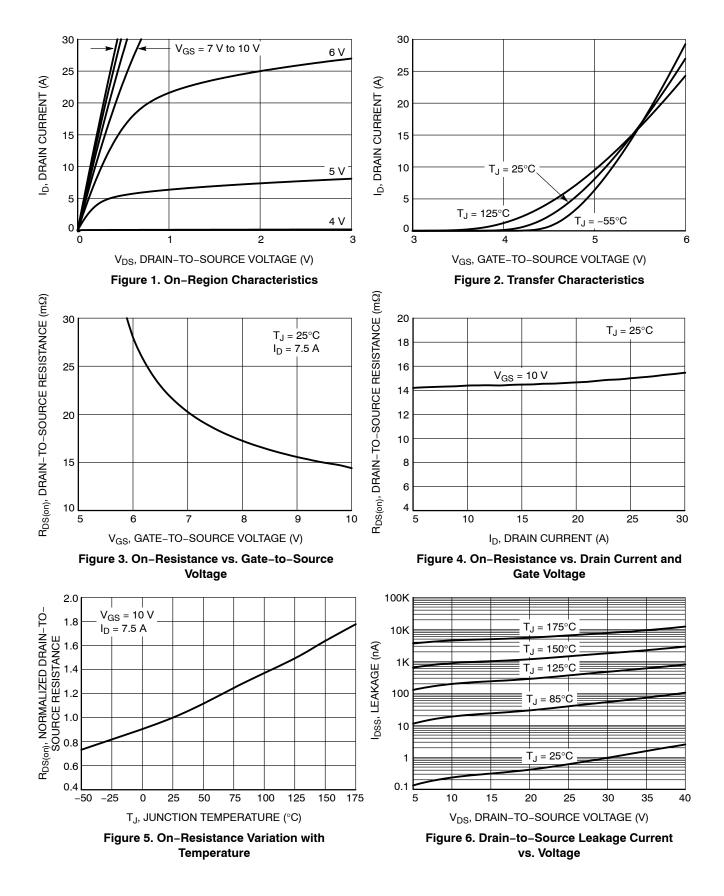
See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

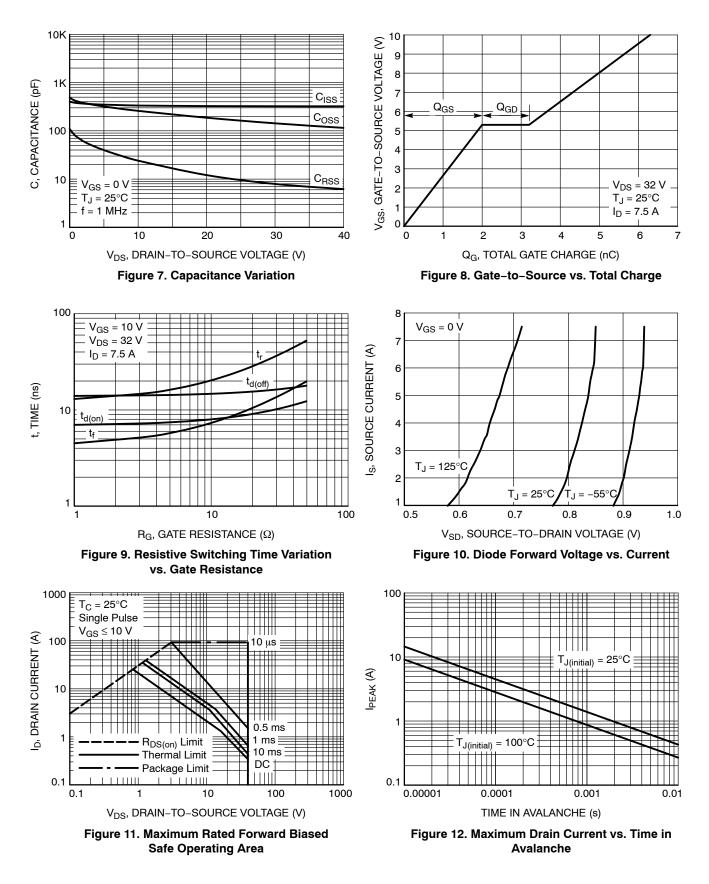
Parameter	Symbol	Test Conc	lition	Min	Тур	Max	Unit
OFF CHARACTERISTICS		-			•		-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 V, I_D$	= 250 μA	40			V
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V_{0}$	$T_J = 25^{\circ}C$			10	μA
		V _{GS} = 0 V, V _{DS} = 40 V	T _J = 125°C			250	1
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _G	_S = 20 V			100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 20 μA	2.5		3.5	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _[₀ = 7.5 A		14.4	17.3	mΩ
Forward Transconductance	9 _{FS}	V _{DS} = 15 V, I _E	₀ = 7.5 A		2		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}				325		pF
Output Capacitance	C _{oss}	$V_{GS} = 0 V, f = V_{DS} = 28$	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 25 V		165		1
Reverse Transfer Capacitance	C _{rss}	v _{DS} = 23 v			10		1
Threshold Gate Charge	Q _{G(TH)}	V_{GS} = 10 V, V_{DS} = 32 V, I_{D} = 7.5 A			1.3		nC
Gate-to-Source Charge	Q _{GS}				2.0		1
Gate-to-Drain Charge	Q _{GD}				1.2		1
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 10 V, V_{DS} = 32 V, I_{D} = 7.5 A			6.3		nC
SWITCHING CHARACTERISTICS (No	te 6)						
Turn-On Delay Time	t _{d(on)}				7		ns
Rise Time	t _r	V _{GS} = 10 V, V _D	s = 32 V,		13		1
Turn-Off Delay Time	t _{d(off)}	I _D = 7.5	A		14		1
Fall Time	t _f	1			4.5		1
DRAIN-SOURCE DIODE CHARACTEF	ISTICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 7.5 A	$T_J = 25^{\circ}C$		0.84	1.2	V
			T _J = 125°C		0.72		1
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dI _S /dt = 100 A/µs, I _S = 7.5 A			18		ns
Charge Time	t _a				7		1
Discharge Time	t _b				11		1
Reverse Recovery Charge	Q _{RR}				6		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
5. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



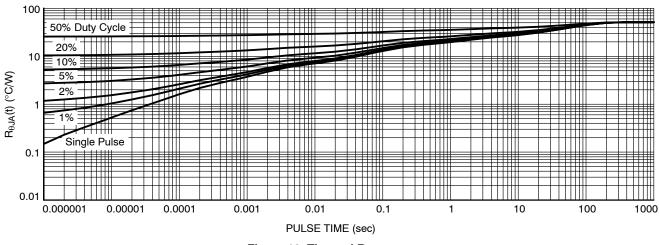


Figure 13. Thermal Response

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVTFS015N04CTAG	15NC	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFWS015N04CTAG	15NW	WDFN8 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





Pb-Free indicator, "G" or microdot " .", may or may not be present.

DATE 23 APR 2012

NOTES:

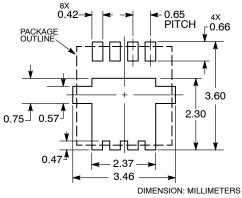
DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS. 1. 2.

3.

ROT	RUSIONS OR GATE BURRS	S.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D	;	3.30 BSC		0	.130 BSC)	
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
E	;	3.30 BSC		0.130 BSC			
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е		0.65 BSC	;	0.026 BSC			
G	0.30	0.41	0.51	0.012	0.016	0.020	
к	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
м	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DOCUMENT NUMBER:	98AON30561E	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.					
DESCRIPTION: WDFN8 3.3X3.3, 0.65P PAGE 1 0							
ON Semiconductor reserves the right the suitability of its products for any pa	ON Semiconductor and a generate and a semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the						

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent-Marking.pdf</u>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor date sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use a a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor houteds for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

TECHNICAL SUPPORT

ON Semiconductor Website: www.onsemi.com

Email Requests to: orderlit@onsemi.com

North American Technical Support: Voice Mail: 1 800–282–9855 Toll Free USA/Canada Phone: 011 421 33 790 2910 Europe, Middle East and Africa Technical Support: Phone: 00421 33 790 2910 For additional information, please contact your local Sales Representative